

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/725,017	URSELL ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Bena Miller	3725	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,836,365	11-1998	Derecktor, Thomas E.	144/287
*	B	US-5,988,243	11-1999	Ayala et al.	144/329
*	C	US-5,722,472	03-1998	Wang, Tian Wang	144/286.1
*	D	US-5,526,856	06-1996	Pedri, Attilio	144/287
*	E	US-4,860,807	08-1989	Vacchiano, Ted	144/286.1
*	F	US-RE35,627	10-1997	Estrem, Jim J.	144/329
*	G	US-5,778,953	07-1998	Braddock, Lawrence D.	144/286.1
*	H	US-6,029,721	02-2000	O'Banion, Michael L.	144/287
*	I	US-			
*	J	US-6,029,721	02-2000	O'Banion, Michael L.	144/287
*	K	US-5,664,612	09-1997	Klemma, Asle	144/286.1
*	L	US-5,273,090	12-1993	Klemma, Asle	144/136.9
*	M	US-5,320,150	06-1994	Everts et al.	144/287

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.